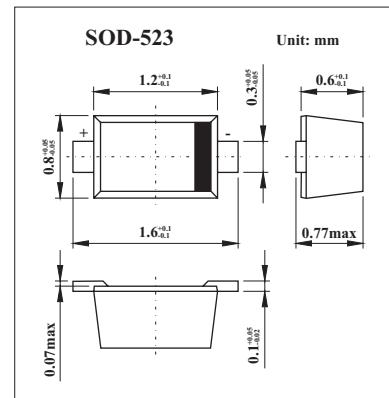


## Silicon PIN diode

### BAP63-02

#### ■ Features

- High speed switching for RF signals
- Low diode capacitance
- Low diode forward resistance
- Very low series inductance.
- For applications up to 3 GHz.



#### ■ Absolute Maximum Ratings Ta = 25 °C

Parameter	Symbol	Min	Max	Unit
continuous reverse voltage	V <sub>R</sub>		50	V
continuous forward current	I <sub>F</sub>		100	mA
total power dissipation Ts ≤ 90 °C	P <sub>tot</sub>		715	mW
storage temperature	T <sub>stg</sub>	-65	+150	°C
junction temperature	T <sub>j</sub>	-65	+150	°C
thermal resistance from junction to soldering point	R <sub>th j-s</sub>		85	K/W

## BAP63-02

■ Electrical Characteristics  $T_a = 25^\circ C$ 

Parameter	Symbol	Conditions	Typ	Max	Unit
forward voltage	$V_F$	$I_F = 50 \text{ mA}$	0.95	1.1	V
reverse leakage current	$I_R$	$V_R = 35 \text{ V}$		10	nA
diode capacitance	$C_d$	$V_R = 0; f = 1 \text{ MHz}$	0.36		pF
		$V_R = 1 \text{ V}; f = 1 \text{ MHz}$	0.32		
		$V_R = 20 \text{ V}; f = 1 \text{ MHz}$	0.25	0.32	
diode forward resistance	$r_D$	$I_F = 0.5 \text{ mA}; f = 100 \text{ MHz}; \text{note 1}$	2.5	3.5	$\Omega$
		$I_F = 1 \text{ mA}; f = 100 \text{ MHz}; \text{note 1}$	1.95	3	
		$I_F = 10 \text{ mA}; f = 100 \text{ MHz}; \text{note 1}$	1.17	1.8	
		$I_F = 100 \text{ mA}; f = 100 \text{ MHz}; \text{note 1}$	0.9	1.5	
isolation	$ s_{21} ^2$	$V_R = 0; f = 900 \text{ MHz}$	15.6		dB
		$V_R = 0; f = 1800 \text{ MHz}$	10.3		
		$V_R = 0; f = 2450 \text{ MHz}$	8.3		
insertion loss	$ s_{21} ^2$	$V_R = 0.5; f = 900 \text{ MHz}$	0.19		dB
		$V_R = 0.5; f = 1800 \text{ MHz}$	0.24		
		$V_R = 0.5; f = 2450 \text{ MHz}$	0.28		
insertion loss	$ s_{21} ^2$	$V_R = 1; f = 900 \text{ MHz}$	0.16		dB
		$V_R = 1; f = 1800 \text{ MHz}$	0.20		
		$V_R = 1; f = 2450 \text{ MHz}$	0.25		
insertion loss	$ s_{21} ^2$	$V_R = 10; f = 900 \text{ MHz}$	0.10		dB
		$V_R = 10; f = 1800 \text{ MHz}$	0.16		
		$V_R = 10; f = 2450 \text{ MHz}$	0.20		
insertion loss	$ s_{21} ^2$	$V_R = 100; f = 900 \text{ MHz}$	0.09		dB
		$V_R = 100; f = 1800 \text{ MHz}$	0.14		
		$V_R = 100; f = 2450 \text{ MHz}$	0.18		
charge carrier life time	$\tau_L$	when switched from $I_F = 10 \text{ mA}$ to $I_R = 6 \text{ mA}$ ; $R_L = 100 \Omega$ ; measured at $I_R = 3 \text{ mA}$	310		$\mu\text{s}$
series inductance	$L_s$	$I_F = 100 \text{ mA}; f = 100 \text{ MHz}$	0.6		nH

Note

1. Guaranteed on AQL basis: inspection level S4, AQL 1.0.

## ■ Marking

Marking	K5
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